Se	earch Notes		

App	licatio	n/Con	trol	No.

10/713,192

Examiner Mike Qi

Applicant(s)/Patent under Reexamination

LEE, WON-HO
Art Unit

2871

SEARCHED			
Class	Subclass	Date	Examiner
349	129	2/9/2007	ZQQ
349	110	2/9/2007	ZQQ
349	111	2/9/2007	ZQQ
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
349	129	2/9/2007	ZQQ
349	110	2/9/2007	ZQQ
349	111	2/9/2007	ZQQ
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SEARCH NOT (INCLUDING SEARCH		)
	DATE	EXMR
East search in US-PGPUB, USPAT,USOCR,FPRS, EPO,JPO,DERWENT,IBM_TDB, (see printout)	2/9/2007	ZQQ
Update searched in the above data bases. (see printout).	2/9/2007	ZQQ
Interference searched. (see printout)	2/9/2007	ZQQ
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